

THE RF VECTOR VOLTMETER—AN IMPORTANT NEW INSTRUMENT FOR AMPLITUDE AND PHASE MEASUREMENTS FROM 1 MHz TO 1000 MHz

A broadband two-channel millivoltmeter and phasemeter simplifies many measurements heretofore often neglected. Included are device gain and loss, impedance and admittance, length inequalities in transmission paths, and precision frequency comparisons.

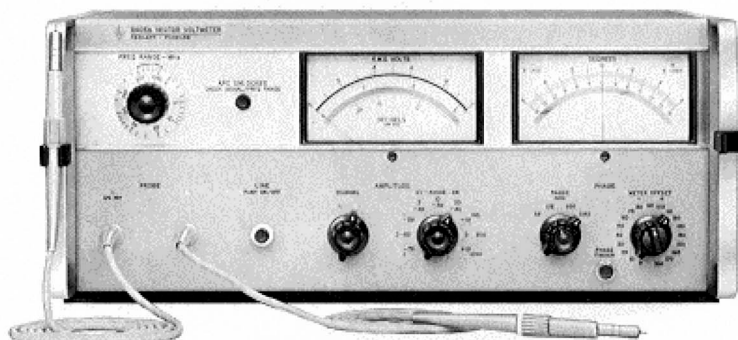


Fig. 1. -hp- Model 8405A Vector Voltmeter measures amplitudes and phase simultaneously. Instrument has frequency range of 1 MHz to 1 GHz, sensitivity of 100 μ V full-scale, dynamic range of 95 dB, phase resolution of 0.1°, and is simple to operate. Thus it makes feasible many measurements which formerly were difficult or impossible.

AN IMPORTANT NEW INSTRUMENT, which seems certain to become one of the major electronic measuring instruments, has recently been developed by the -hp- Microwave Division. The RF Vector Voltmeter (Fig. 1) is a two-channel millivoltmeter and phasemeter: it measures the voltage in channel A, and simultaneously measures the phase angle between the fundamental components of the signals in channels A and B; it may then be switched to measure the voltage in channel B so that gain or loss may be determined. It makes these measurements over a broad frequency range (1 to 1000 MHz) in a part

of the spectrum where information is often peculiarly difficult to obtain.

Voltage and phase are so fundamental in electrical engineering that the new Vector Voltmeter has an extraordinary number of applications. It can, for example, measure complex or vector parameters such as impedance or admittance, amplifier gain and phase shift, complex insertion loss or gain, complex reflection coefficient, two-port network parameters, and filter transfer functions. It can also be used as a selective receiver and as a design tool: possible applications are detecting RF leakage, measuring antenna character-

istics, detecting Miller effects in tuned RF amplifiers, tuning feedback amplifiers, measuring the electrical length of cables, measuring group delay, and many others.

Although adequate voltmeters for measuring amplitudes over a wide frequency range have been available for some time, there has been no equally convenient means for measuring phase. Consequently, simultaneous measurements of voltage and phase have not always been easy to make. Most systems which are able to measure phase angles require several control adjustments for each measurement, and many of them

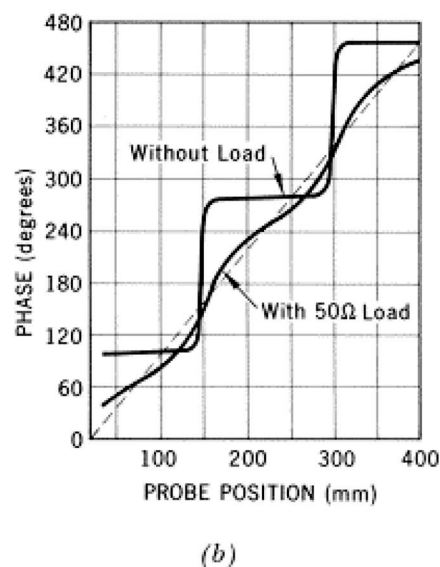
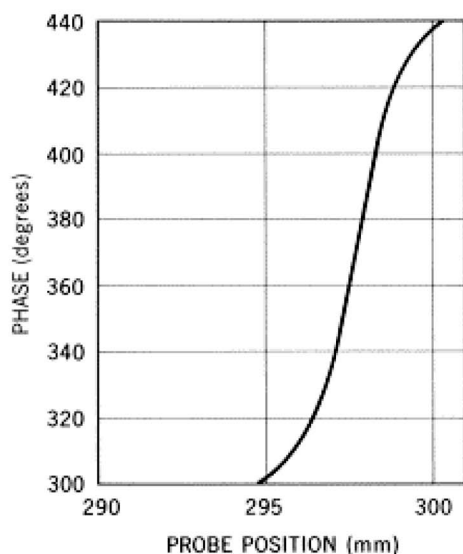
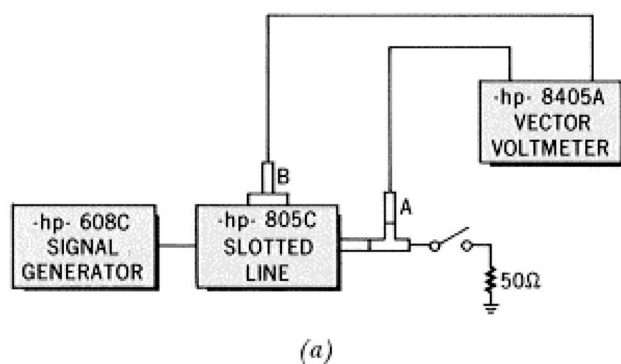


Fig. 3. Demonstration of phase-measuring capabilities of Vector Voltmeter. Phasemeter readings vs. slotted-line probe positions for setup of (a) are plotted in (b). Steepest portion of (b) curves is shown expanded in (c). Maximum rate of change of phase of $50^\circ/\text{mm}$, or 2° per human hair diameter, is easily measured. With slotted line terminated in 50 ohms, maximum deviation of phase from linear, theoretically 22.8° for measured VSWR of 2.26, is measured as 22° . Frequency is 1.003 GHz.

PHASE-MEASURING CAPABILITIES

Figs. 3(b) and 3(c) demonstrate the phase-measuring capabilities of the Vector Voltmeter. They show, first of all, how the high phase resolution of the VVM makes possible very precise measurements of length. Fig. 3(b) also includes an example of the phase-measurement accuracy of the instrument.

To obtain the data for Figs. 3(b) and 3(c), a 1-GHz signal was applied first to an unloaded slotted line and then to the same slotted line with a 50-ohm load [see block diagram, Fig. 3(a)]. Probe A of the VVM was placed at the output of the slotted line, and probe B was attached to the movable slotted-line probe. Fig. 3(b) is a plot of the

phasemeter readings versus the position of the slotted-line probe. The measured curve closely follows the theoretical curve for an open-circuited lossless line.

Without the 50-ohm load, the standing-wave ratio on the line was 50.5. This was determined by measuring the maximum and minimum voltages on the line with the voltmeter of the VVM switched to channel B. The phase-vs-position curve is the step-like curve of Fig. 3(b), and Fig. 3(c) shows one of the steep portions of this curve with an expanded horizontal scale. The maximum rate of change of phase can be determined from Fig. 3(c) to be 50° per millimeter, or 0.05° per micrometer. Thus, a change equal to the diameter

of a human hair in the position of the slotted-line probe was accompanied by about a 2° phase change, and was easily resolved by the high-resolution (0.1°) phasemeter.

With the 50-ohm load, the VSWR was 2.26. Had the VSWR been 1.0, the phase-vs-position curve would have

CORRECTION

In the article 'RFI Measurements Down to 10 kHz With Spectrum Analyzer Converter,' Vol. 17, No. 7, March, 1966, the mixer input ports in Fig. 4 are incorrectly labeled. Top port should be labeled 'L,' and center port should be labeled 'X.' It is possible to burn out the mixer if the circuit is not connected properly, or if local oscillator power is too high. Optimum LO power is about 5 mW. Lower power levels can be used, but the third-order intermodulation products of the mixer will be larger.

been linear, as shown by the dashed line in Fig. 3(b). The theoretical maximum deviation from linear of the phase curve for a VSWR of 2.26 is

$$\Delta\phi = \arcsin \frac{2.26 - 1}{2.26 + 1} = 22.8^\circ.$$

The measured maximum deviation shown in Fig. 3(b) is about 22° .

AMPLIFIER MEASUREMENTS

Fig. 4(b) shows curves of gain, phase, and group delay versus frequency for a transistor amplifier stage operating in the 10-to-12-MHz range. The curves were measured with the Vector Voltmeter in the setup of Fig. 4(a). Compared with previously-available methods, the time and effort required to take the data were minimal.

Two sets of curves are shown in Fig. 4(b). With the switch shown in Fig. 4(a) in the closed position, the gain of

the second amplifier stage was reduced to zero. The solid curves of Fig. 4(b) were obtained with the switch open (second stage gain > 1) and the dashed curves were obtained with the switch closed. The difference between the curves shows that the impedance seen by the first stage has been changed by the Miller effect of the collector-to-base capacitance of the second transistor and the gain of the second stage.

Besides amplitude and phase curves, Fig. 4(b) shows group-delay curves, in which delay distortion produced by the Miller effect is apparent. A group delay curve can be obtained either by plotting the slope of the phase curve, or directly from the phasemeter. By changing the input frequency in increments of 2.78 kHz, or 27.8 kHz, or 278 kHz, etc., the group delay can be read directly from the corresponding

changes in the phasemeter readings. The scale factors will in this case be $1\mu\text{s}$, 100 ns, or 10 ns, etc., per degree, since $1\mu\text{s} = 1^\circ$ at 2.78 kHz, and so on. Group delay information is very useful in cable testing, where constant time delay for all frequencies is desirable.

MEASUREMENTS OF TRANSISTOR AND NETWORK PARAMETERS

Another important application for the new VVM is measuring transistor gain and other transistor parameters. The wide frequency range of the VVM, and its ability to measure very small signals, make it well-suited for transistor measurements.

Fig. 5(a) shows a test setup which is being used at -hp- to measure transistor scattering parameters, or s -parameters. The s -parameters contain the same in-

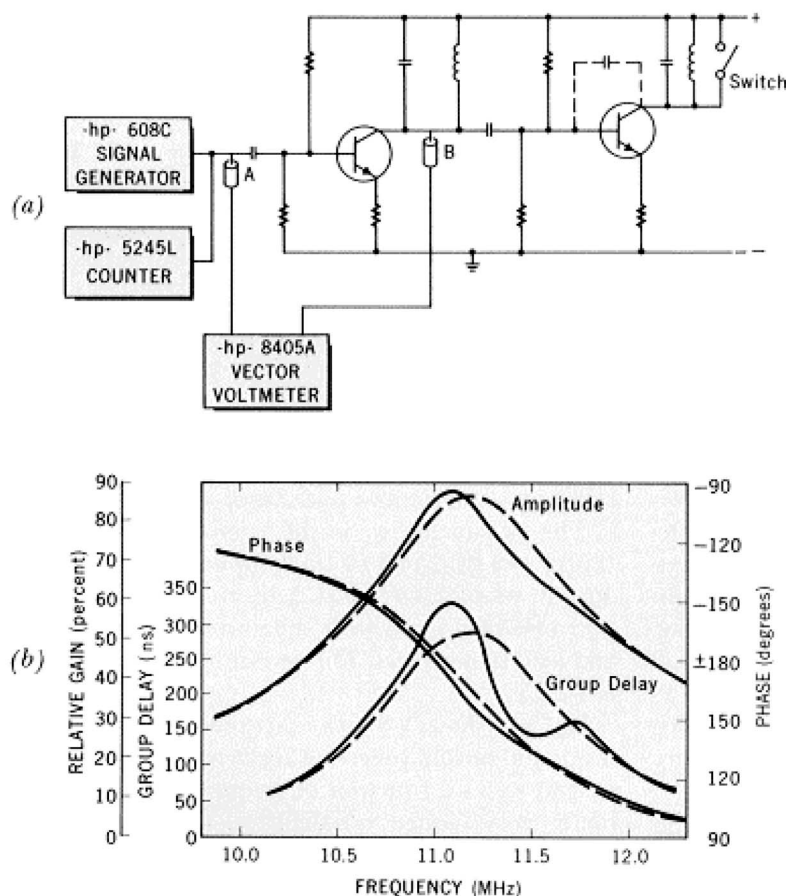


Fig. 4. Typical amplifier gain, phase, and group delay measurements, made with Vector Voltmeter in setup shown in (a). Solid curves of (b) were taken with switch on second amplifier stage open, so that second-stage gain was greater than one. Dashed curves of (b) were measured with switch closed, second-stage gain = 0. Difference

between curves shows Miller effect of second-stage collector-base capacitance. Group delay curves can be obtained by differentiating phase curve, or by changing input frequency in increments of $2.78 \times 10^3 \text{ kHz}$ and determining delay from corresponding phasemeter changes with scale factor of $10^{-n} \mu\text{s}$ per degree, where $n = 0, \pm 1, \pm 2, \dots$

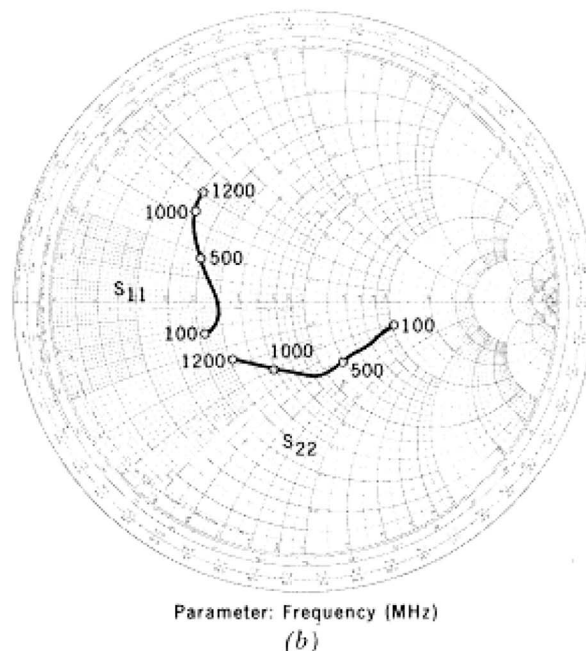
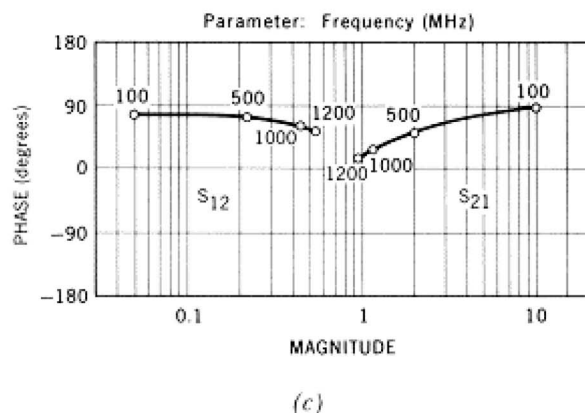
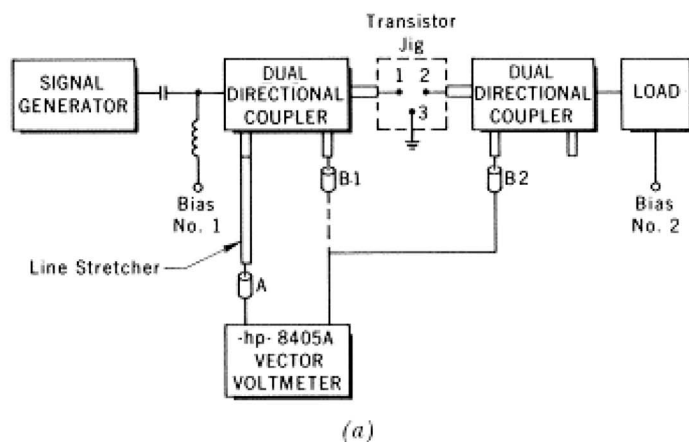


Fig. 5. (a) Setup for measurement of transistor scattering parameters, or s -parameters. Input reflection coefficient s_{11} is measured with probe B in position B₁. Forward gain s_{21} is measured with probe B in position B₂. Output reflection coefficient s_{22} and reverse gain s_{12} are measured by turning transistor around in special jig and making same measurements as for s_{11} and s_{21} , respectively. (b) Amplitude and phase of s_{11} and s_{22} measured with Vector Voltmeter are plotted on Smith chart using polar coordinates. Normalized input and output impedances can then be read on impedance scales. (c) s_{12} and s_{21} for same transistor. Transistor was in grounded-emitter configuration with 50-ohm source and load impedances.

formation as other common types of two-port network parameters, such as y -, z -, h -, or a -parameters, but are much easier to measure and to work with at high frequencies because, unlike the other parameters, s -parameters are not defined in terms of short circuits or open circuits, which are difficult to obtain at high frequencies. Now that transistor gain-bandwidth products greater than 1000 MHz are becoming common, new methods for specifying transistor high-frequency performance are coming into use. The s -parameters will probably be employed for this pur-

pose more often in the future.²

The parameter s_{11} is the complex reflection coefficient at the input, or port 1, of a two-port network, with the network terminated in equal source and load impedances, usually 50 ohms. The reflection coefficient at port 2 is s_{22} .

The parameter s_{21} is the complex transducer gain or loss from input to output, or port 1 to port 2, of a two-port network, again with equal source and load impedances. The reverse gain is s_{12} .

Fig. 5(b) shows a Smith-chart plot of input and output reflection coefficients s_{11} and s_{22} as a function of frequency for a high-frequency transistor. The measurements were made over a wide measurement range from 100 to 1200 MHz with the new Vector Voltmeter, using the setup of Fig. 5(a). The Smith chart is useful for plotting s_{11} and s_{22} because the amplitude and phase of these reflection coefficients can be plot-

ted using the polar coordinates of the chart, and then the normalized input reactance and resistance of the network can be read directly from the reactance and resistance scales.

Fig. 5(c) shows plots of reverse and forward gain s_{12} and s_{21} obtained with the same transistor as Fig. 5(b), in the circuit of Fig. 5(a).

All of the measurements discussed here, as well as many others, some of which are described briefly on pages 7, 10 and 11 can be made quickly and easily with the new Vector Voltmeter. In the past, these measurements were difficult to make, and often were not made at all, because of the difficulty of obtaining phase information.

SAMPLING MIXERS

Fig. 7 is a block diagram of the sampling-type harmonic mixers, which are located in the probes. These mixers are similar to those used in $-hp-$ sampling oscilloscopes. They operate on a stroboscopic principle, sampling a high-

TIME SIGNAL ADJUSTMENT

Time signals broadcast by NBS Standards Radio Station WWVB (60 kHz) will be retarded 200 milliseconds at 0000 hours, Universal Time, on June 1, 1966, according to an announcement from the National Bureau of Standards. This adjustment is in accordance with the policy of maintaining the WWVB pulses, which conform to the atomic-referenced second, within 100 milliseconds of time pulses referred to Universal Time.

² George E. Bodway, "Two-Port Power Flow Analysis of Linear Active Circuits Using the Generalized Scattering Parameters," to be published.



Fig. 6. Design team for *-hp-* Model 8405A Vector Voltmeter included (l. to r.) Fritz K. Weinert, final-phase project leader, William R. Hanisch, Allen Baghdasarian, Siegfried H. Linkwitz, Jeffrey L. Thomas, and Roderick Carlson, initial-phase project leader.

frequency periodic input signal at a slightly different phase at each sampling instant and reconstructing a low-frequency image of the signal from the samples. The time between sampling pulses is determined by the frequency of the voltage-tunable local oscillator (VTO), which is controlled by the phase-locked loop.

In operation, the sampler gate is opened for about 300 picoseconds. The input voltage at this time is stored in a 'zero-order hold' circuit until the next sample. The output waveform is a faithful replica of the input, constructed in small steps.³ Negative feedback is employed to stabilize the voltage conversion loss at 0 dB (output amplitude is same as input amplitude) and to give a high input impedance.

The two probes are ac-coupled and permanently attached to the instrument with 5-foot cables. Loading of the system under test is minimized by the high input impedance of the probes (0.1 megohm shunted by 2.5 pF; with divider, 1 megohm shunted by 2 pF).

AUTOMATIC PHASE CONTROL

The phase-locked loop, shown in Fig. 8, tunes the instrument to the signal frequency. The loop is preceded by a high-gain amplifier-limiter which

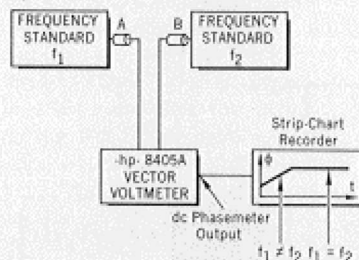
³ This process is essentially distortionless; distortion introduced by the sample-and-hold system does not appear in the IF signals until the 50th harmonic, which is usually much higher than the highest significant harmonic in the input signal.

THE VECTOR VOLTMEETER AS A PRECISION FREQUENCY COMPARATOR

Adjusting a precision oscillator so that its frequency is the same as that of a standard calls for a precise frequency comparison between two highly stable signal sources. Such frequency comparisons are also needed in studies of aging effects, or long-term stability, in precision oscillators. In these comparisons, frequency differences of a few parts in 10^{12} are significant and must be detected.

Most methods for comparing the frequencies of two stable oscillators require long time periods to achieve the required precision. For example, it takes about one day to compare two 5-MHz frequency standards to a precision of one part in 10^{13} , by the best of these methods.

By using the Vector Voltmeter to detect the phase difference between the two oscillators, the time required to achieve a precision of one part in 10^{13} can be reduced to a few minutes, at typical standard frequencies of 1 MHz or more. The block diagram shows the measurement arrangement.



If the frequencies of the two oscillators are the same their phase difference will be constant. If the frequencies differ, the phasemeter reading will change at a rate given by

$$\frac{\Delta\phi}{\Delta t} = 360 \Delta f$$

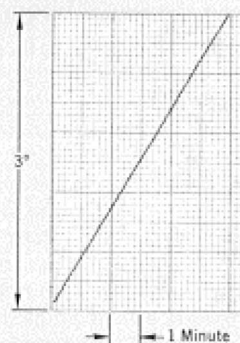
where $\Delta\phi$ = phase change in degrees, indicated by VVM

Δt = time in seconds required for phase change $\Delta\phi$

Δf = frequency difference in Hz between input signals.

The direction of the phase change tells which frequency is higher: clockwise rotation of the phasemeter pointer indicates that the frequency in channel B is higher than that in channel A.

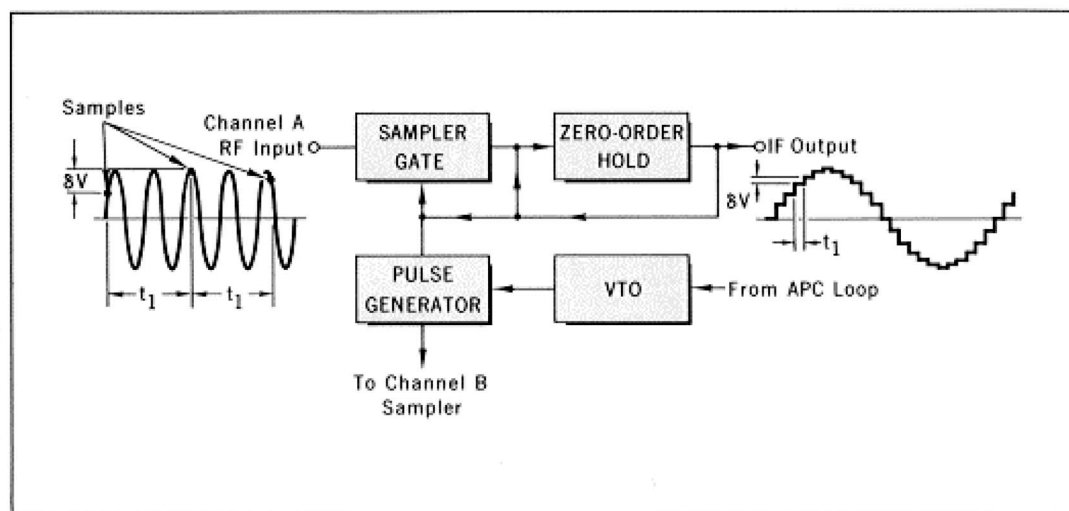
The phase change and direction of change can be recorded on a strip-chart recorder by connecting the recorder to the dc phasemeter output jack on the rear panel of the VVM. The record shown is a typical recorder trace for two 1-MHz oscillators with a frequency offset of 2.3×10^{-6} Hz, or 2.3 parts in 10^{11} . The time



scale is 12 seconds per division, and the full-scale phase difference is 3° . The slope of the trace can be determined within less than one minute, whereas older methods would have required much longer to achieve this precision.

When the Vector Voltmeter is used as a precision frequency comparator, the two oscillators must have low noise, the oscillator frequencies must fall within the range of the VVM (1 MHz to 1 GHz), and the oscillator frequencies must differ by less than a few hertz. Oscillators whose frequencies differ by more than a few hertz should first be tuned coarsely using a counter or an oscilloscope.

Fig. 7. Block diagram of sampling-type harmonic mixers used in new VVM. Mixers operate on stroboscopic principle, sampling RF signal at different points in cycle at successive sampling instants. RF waveforms are reconstructed in small steps at intermediate frequency: fundamental component of RF signal is transposed to 20 kHz, second harmonic to 40 kHz, and so on. Feedback keeps IF voltage equal to RF voltage.



delivers a constant output regardless of the input voltage.

When an RF signal is applied to channel A and the instrument is not tuned properly, the IF is not 20 kHz, and the search generator produces a ramp voltage which adjusts the frequency of the VTO. This changes the time between samples and, consequently, changes the intermediate frequency. When the IF reaches 20 kHz, the loop locks and controls the VTO so as to correct for changes in VTO frequency, signal frequency, or phase modulation.

When the loop is locked, the difference between the signal frequency and

a harmonic of the VTO frequency is exactly the 20-kHz reference oscillator frequency:

$$f_{\text{sig}} - nf_{\text{VTO}} = \pm 20 \text{ kHz.}$$

The 20-kHz IF can be either the 'inverted' mode or the 'noninverted' mode, depending upon whether the signal is 20 kHz below or 20 kHz above a VTO harmonic. The IF phase difference is identical to the RF phase difference only for the noninverted mode. For the inverted mode, the phase angle is correct, but is lagging when the RF phase angle is leading. A sideband decision circuit detects the sideband mode and starts the search

generator again if the IF mode is inverted. The time required to complete the tuning operation is about 10 milliseconds.

Overall gain of the phase-locked loop is a linear function of the harmonic number to which the signal is locked. A variable attenuator adjusts the loop gain to an optimal value for any signal frequency so that the gain will be sufficient to ensure phase lock but not so high that the loop oscillates. The attenuator control knob is labeled FREQUENCY RANGE, and has 21 overlapping octave-wide bands.

METER CIRCUITS

The voltmeter and phasemeter cir-

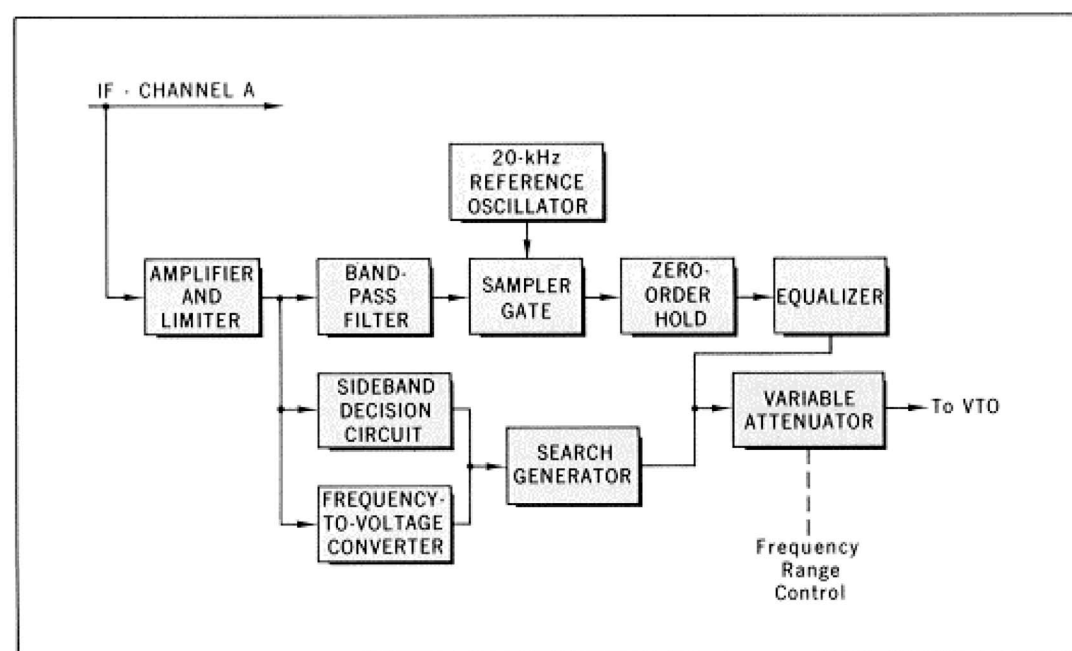


Fig. 8. Block diagram of automatic phase control (APC) circuit, which tunes and phase-locks Vector Voltmeter to channel A signal. APC loop adjusts frequency of voltage-tuned local oscillator (VTO) which generates sampling pulses for mixers, thus keeps IF at 20 kHz. APC requires only 10 ms to tune meter, and remains locked even if input frequency changes at rates up to 15 MHz/s. Sideband decision circuit ensures that $f_{\text{sig}} - nf_{\text{VTO}}$ is always +20 kHz, never -20 kHz.

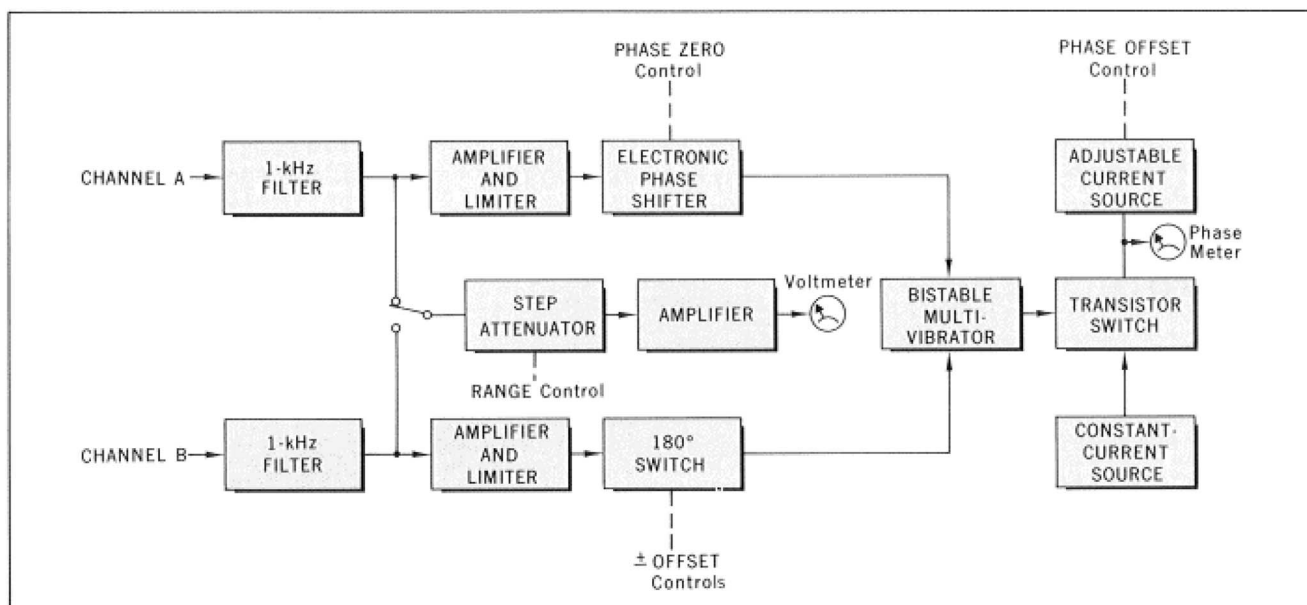


Fig. 9. Block diagram of voltmeter and phasemeter circuits. Amplifier-limiters make phase readings independent of signal levels.

circuits are shown in Fig. 9. The 20-kHz phasemeter has identical amplifiers and limiters in both channels so that the meter reading is independent of the input signal levels.

The phase detector is a bistable multivibrator which is triggered to one of its stable states by channel A and to the other by channel B. The multivibrator operates a transistor switch, which turns the meter current on and off. Another meter input current provides the phase offset, which is adjustable in 10° steps. This kind of phase detector has a very linear characteristic and gives precise phase offset steps in spite of extreme environmental conditions or intermediate-frequency shifts.

ACKNOWLEDGMENTS

The Vector Voltmeter design was initiated by a study⁴ made by Chu-Sun Yen, Kay B. Magleby, and Gerald J. Alonzo of the -hp- Advanced Research and Development Laboratories. The design group for the Vector Voltmeter has included Roderick Carlson, Allen Baghdasarian, William R. Hanisch, Siegfried H. Linkwitz, Jeffrey L. Thomas, Giacomo J. Vargiu and the undersigned.

—Fritz K. Weinert

DESIGN LEADERS



RODERICK CARLSON

Rod Carlson joined -hp- in 1958 as a development engineer. He participated in the design of the -hp- 160A Oscilloscope and was project leader for the development of the -hp- 185A Sampling Oscilloscope. Later he became section manager for sampling oscilloscope development. He transferred to the -hp- Microwave Division in 1964, and was the project leader during the initial development of the -hp- 8405A Vector Voltmeter. He then became manager of the signal analysis section of the Microwave Laboratory, the section concerned with wave and spectrum analyzers, broadband detectors, and power measurement.

Rod holds a BSEE degree from Cornell University. He is a member of IEEE, Tau Beta Pi, Eta Kappa Nu, and Phi Kappa Phi. Before joining -hp-, Rod spent five years as an instrumentation engineer for Cornell Aeronautical Laboratory, dealing with aircraft stability and control under flight conditions.



FRITZ K. WEINERT

Fritz Weinert graduated Magna Cum Laude from Ingenieurschule Gauss, Berlin, Germany, with a degree in electrical communications engineering and precision mechanics. Beginning in 1947, he was associated with several German firms as a development engineer for carrier telephone systems, and as project engineer for a variety of projects dealing with electronic test instruments, antennas, and fields. After coming to the United States in 1960, Fritz spent four years as a project engineer in the development of RFI instrumentation.

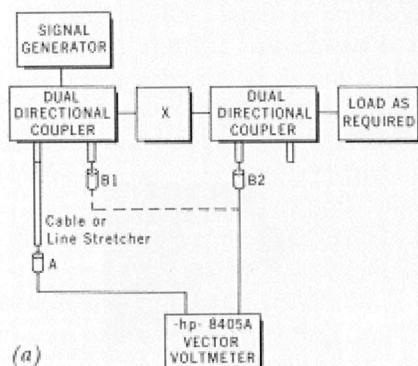
Fritz joined -hp- in 1964, becoming project leader for the final development of the 8405A Vector Voltmeter. He is now a project leader in the network analysis section of the -hp- Microwave Laboratory. Fritz holds patents and has published papers dealing with pulse circuits, tapered-line transformers, digital tuned circuits, and shielding systems. He has taught undergraduate electronics and mathematics.

⁴ Chu-Sun Yen, "Phase-Locked Sampling Instruments," IEEE Transactions on Instrumentation and Measurement, Vol. IM-14, Nos. 1 and 2, March-June, 1965.

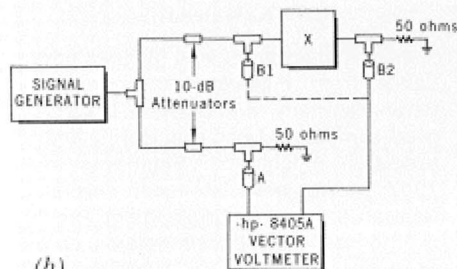
- COMPLEX INSERTION LOSS OR GAIN
- COMPLEX REFLECTION COEFFICIENT
- COMPLEX IMPEDANCE OR ADMITTANCE
- TWO-PORT NETWORK PARAMETERS
- ANTENNA IMPEDANCE AND PHASE CHARACTERISTICS

The arrangement shown in (a) is limited to the frequency range of the directional couplers (usually >200 MHz). The cable or line-stretcher may be needed at the higher frequencies to compensate for phase shift in the directional couplers and other circuitry. A simpler arrangement, useful at lower frequencies, is shown in (b).

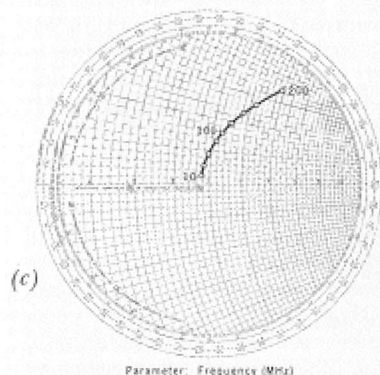
Reflection coefficients, input parameters, and impedances are measured with probe B in position B1. Transmission parameters, loss, and gain are measured with probe B in position B2. Input impedance can be determined by plotting magnitude and phase of reflection coefficient on Smith chart and reading normalized impedance on resistance and reactance scales.



(a)



(b)



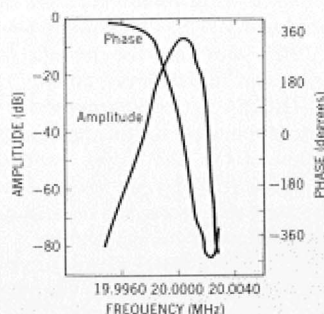
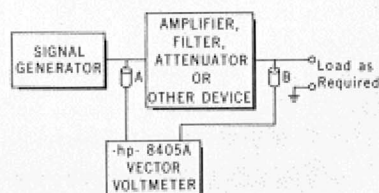
(c)

Expanded Smith chart plot of reflection coefficient of 50-ohm $\pm 1\%$ metal film resistor attached to BNC connector. Circuit was (a) with probe B in position B1, resistor as device X, and only one directional coupler.

- GAIN AND PHASE OF ONE OR MORE AMPLIFIER STAGES
- GROUP DELAY AND DISTORTION
- COMPLEX TRANSMISSION COEFFICIENTS
- FILTER TRANSFER FUNCTIONS
- ATTENUATION

Measurements of gain, phase shift, and group delay of any device can be made by placing one probe (A or B) of the Vector Voltmeter at the input of the device and the other probe at the output. The difference between channel A and channel B voltmeter readings in dB is the gain or loss. Phasemeter reading is the phase shift. Group delay is the slope of the phase-vs-frequency curve.

If signal frequency must be measured more accurately than is possible with the signal-generator dial, a counter may be used to measure frequency, or a frequency synthesizer may be used as a signal generator.



Gain and phase shift of -hp- Model 8442A 20-MHz Crystal Filter as measured with new RF Vector Voltmeter.

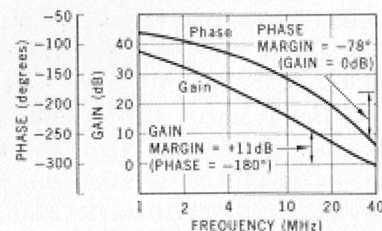
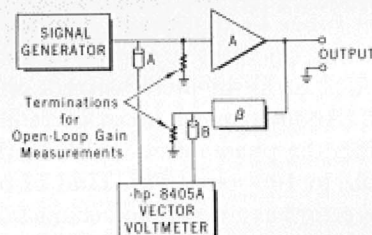
- OPEN-LOOP GAIN OF FEEDBACK AMPLIFIERS
- GAIN AND PHASE MARGINS

Closed-loop gain of a feedback amplifier is $\frac{A}{1 - A\beta}$ (a complex number).

$A\beta$ is open-loop gain. If $-A\beta = -1$, the feedback is positive and oscillations occur.

Important quantities in feedback amplifier design are gain margin and phase margin, which are measures of the degree of stability of an amplifier. Gain margin is the magnitude of $-A\beta$, in dB, at the frequency for which the phase of $-A\beta$ is -180° . Phase margin is the difference between -180° and the phase of $-A\beta$ at the frequency for which the magnitude of $-A\beta$ is 0 dB. Typical gain margins are -10 dB to -40 dB, typical phase margins greater than 30° .

The Vector Voltmeter greatly simplifies the design of feedback amplifiers and oscillators by giving both amplitude and phase of open-loop gain simultaneously and quickly.



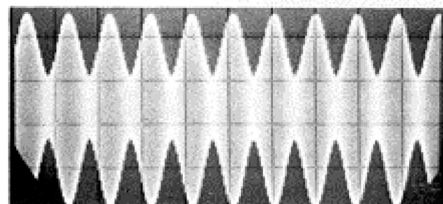
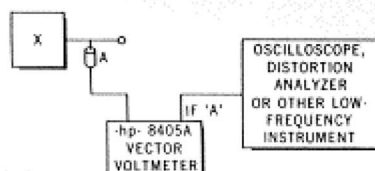
Open-loop gain and phase shift for a transistor amplifier circuit as measured with RF Vector Voltmeter. Amplifier was unstable, as gain and phase margins indicate.

METER MEASUREMENTS

- AMPLITUDE MODULATION INDEX
- RF DISTORTION
- CONVERSION OF LOW-FREQUENCY INSTRUMENTS TO SAMPLING INSTRUMENTS FOR OBSERVATION AND MEASUREMENT OF HIGH-FREQUENCY SIGNALS

Device X is any signal source, 1 MHz to 1 GHz. The Vector Voltmeter converts the fundamental of the RF signal to a 20-kHz IF, the second harmonic to 40 kHz, and so on, so RF waveforms are preserved in the IF signals. The IF output can be used as the input to a low-frequency oscilloscope, distortion analyzer, wave analyzer, or other instrument.

For amplitude-modulated signals, the voltmeter is synchronized to the carrier frequency f_c and the sidebands $f_c \pm \Delta f$ are reproduced at the IF as $20 \text{ kHz} \pm \Delta f$. Modulation index can be measured using an oscilloscope.



20-kHz IF output of Vector Voltmeter observed on *hp-120B* Oscilloscope (bandwidth = 450 kHz). Input to VVM was 300-MHz carrier, amplitude modulated by 1-kHz signal. Oscilloscope was synchronized to modulating signal only.

- ELECTRICAL LENGTH OF CABLES
- PHASE TRACKING BETWEEN SIGNAL PATHS

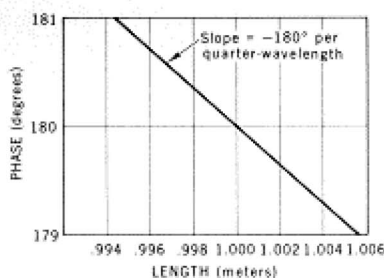
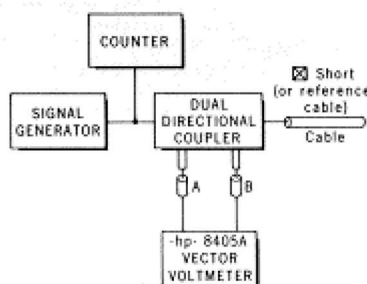
The electrical length of a cable can be adjusted precisely using the phase resolution of the Vector Voltmeter. One arrangement for doing this is shown in the block diagram.

To cut a cable to an electrical length of one-quarter wavelength at frequency f , the signal generator is first tuned precisely to frequency f . Next, with a short circuit at the output of the directional coupler, the system is calibrated by adjusting the PHASE ZERO control of the VVM until the phase-meter reads 180° . Then the short circuit is replaced by the cable and the cable length is adjusted until the phase-meter again reads 180° . The electrical length of the cable is then one-quarter wavelength.

A cable can be adjusted to the same electrical length as another cable by 1) connecting the first cable to the directional coupler and noting the phase-meter reading, and 2) connecting the second cable and cutting it until the phase-meter reading is the same as for the first cable.

Another method for adjusting two cables to the same length is simply to drive both cables with the same signal source and measure the phase difference between the cable output signals with the VVM. Zero degrees phase difference indicates equal electrical lengths. Phase tracking between any two signal paths can be measured in the same way, that is, by driving both paths with the same source and measuring the phase difference at the path outputs with the VVM.

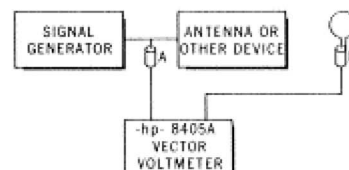
If the cable or cables must be longer than one-quarter wavelength at the frequencies within the range of the VVM, cable length must first be determined to within one-quarter wavelength by other means (e.g., time domain reflectometry).



Phase versus length of cable for system shown in block diagram, calibrated at 75 MHz (quarter-wavelength = 1 m). Phase resolution of VVM is 0.1° , allowing length to be determined within 0.6 mm at 75 MHz, or more accurately at higher frequencies.

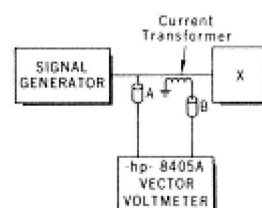
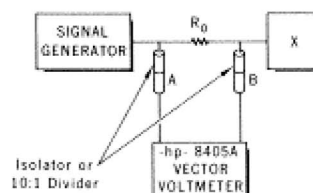
- SELECTIVE RECEIVER
- NEAR-FIELD ANTENNA CHARACTERISTICS
- RF LEAKAGE

The Vector Voltmeter can be used as a selective receiver by synchronizing channel A to the desired frequency or signal, and equipping the channel B probe with an antenna. Meter bandwidth of the VVM is 1 kHz. RF leakage from any device can be detected by this technique. Antenna characteristics can be measured also.



- COMPLEX IMPEDANCE AND ADMITTANCE (AT FREQUENCIES BELOW 100 MHz)

Two simple techniques for measuring impedances at lower frequencies are shown in the accompanying diagrams. These methods are useful if the probe and circuit impedances are negligible in comparison with the unknown and if the reactance of the current transformer or resistor is small.



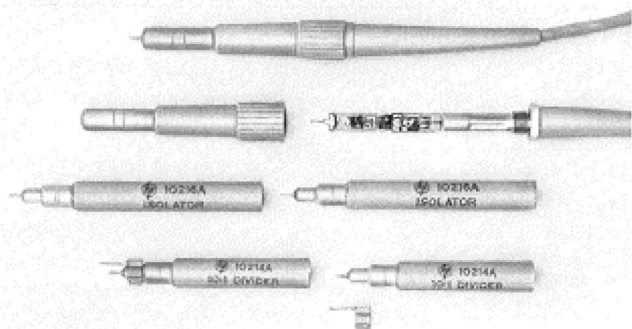


Fig. 10. Probes and accessories for -hp- Model 8405A Vector Voltmeter. Top to bottom: assembled probe; exploded view of probe, showing sampler circuit; isolators, 10:1 dividers, and ground clips supplied with probes. Isolators (or dividers) and ground clips are used when probing by hand in arbitrary circuits. (Teas and adapters are available for probing in 50-ohm coaxial systems.) Dividers extend upper limit of voltmeter range to 10 V. See Specifications for details.

SPECIFICATIONS

-hp- MODEL 8405A VECTOR VOLTMETER

Instrument Type: Two-channel sampling RF millivoltmeter-phasermeter which measures voltage level in two channels and simultaneously displays the phase angle between the two signals.

Frequency Range: 1 MHz to 1 GHz in 21 overlapping octave bands (lowest band covers two octaves).

Meter Bandwidth: 1 kHz.

Tuning: Automatic within each band. Automatic phase control (APC) circuit responds to the channel A input signal. Search and lock time, approximately 10 millise; maximum sweep speed, 15 MHz/sec.

Voltage Range:

Channel A: 1.5 mV to 1 V rms from 1 to 5 MHz; 300 μ V to 1 V rms, 5 to 500 MHz; 500 μ V to 1 V rms, 500 MHz to 1 GHz; can be extended by a factor of 10 with 10214A 10:1 Divider.

Channel B: 100 μ V to 1 V rms full scale (input to channel A required); can be extended by a factor of 10 with 10214A 10:1 Divider.

Meter Ranges: 100 μ V to 1 V rms full scale in 10-dB steps.

Full-Scale Voltage Accuracy: Within $\pm 2\%$ 1 to 100 MHz, within $\pm 6\%$ to 400 MHz, within $\pm 12\%$ to 1 GHz, not including response to test-point impedance*.

Voltage Response to Test Point Impedance: ± 0 , -2% from 25 to 1000 ohms. Effects of test-point impedance are eliminated when 10214A 10:1 Divider or 10216A Isolator is used.

Residual Noise: Less than 10 μ V as indicated on the meter.

Phase Range: 360°, indicated on zero-center meter with end-scale ranges of ± 180 , ± 60 , ± 18 , and ± 6 °. Meter indicates phase difference between the fundamental components of the input signals.

Resolution: 0.1° at any phase angle.

Meter Offset: ± 180 ° in 10° steps.

Phase Accuracy: Within ± 1 °, not including phase response vs. frequency, amplitude, and test-point impedance*.

Phase Response vs. Frequency: Less than ± 0.2 ° 1 MHz to 100 MHz, less than ± 3 ° 100 MHz to 1 GHz.

Phase Response vs. Signal Amplitude: Less than ± 2 ° for an amplitude change from 100 μ V to 1 V rms.

Phase Response vs. Test Point Impedance*:

Less than ± 2 ° 0 to 50 ohms, less than -9 ° 25 to 1000 ohms. Effects of test-point impedance are eliminated when 10214A 10:1 Divider or 10216A Isolator is used.

Isolation Between Channels: Greater than 100 dB 1 to 400 MHz, greater than 75 dB 400 MHz to 1 GHz.

Input Impedance (nominal): 0.1 megohm shunted by approximately 2.5 pF; 1 megohm shunted by approximately 2 pF when 10214A 10:1 Divider is used; 0.1 megohm shunted by approximately 5 pF when 10216A Isolator is used, ac coupled.

Maximum ac Input (for proper operation): 3 V p-p (30 V p-p when 10214A 10:1 Divider is used).

Maximum dc Input: ± 150 V.

20 kHz IF Output (each channel): Reconstructed signals, with 20 kHz fundamental components, having the same amplitude, waveform, and phase relationship as the input signals. Output impedance, 1000 ohms in series with 2000 pF, BNC female connectors.

Recorder Output:

Amplitude: 0 to ± 1 Vdc $\pm 6\%$ open circuit, proportional to voltmeter reading. Output impedance, 1000 ohms; BNC female connector.

Phase: 0 to ± 0.5 Vdc $\pm 6\%$, proportional to phase meter reading; less than 1% effect on Recorder Output and meter reading when external load is $\geq 10,000$ ohms; BNC female connector.

RFI: Conducted and radiated leakage limits are below those specified in MIL-I-6181D and MIL-I-16910C except for pulses emitted from probes. Spectral intensity of these pulses is approximately 60 μ V/MHz; spectrum extends to approximately 2 GHz. Pulse rate varies from 1 to 2 MHz.

Power: 115 or 230 V $\pm 10\%$, 50 to 400 Hz, 35 watts.

Weight: Net 30 lbs. (13.5 kg). Shipping 35 lbs. (15.8 kg).

Dimensions:

16 $\frac{1}{4}$ in. wide, 7 $\frac{1}{2}$ in. high, 18 $\frac{1}{2}$ in. deep (425 x 185,2 x 467 mm) overall. Hardware furnished for conversion to rack mount 19 in. wide, 6 $\frac{1}{2}$ in. high, 16 $\frac{1}{2}$ in. deep behind panel (483 x 177,2 x 416 mm).

Accessories Furnished:

10214A 10:1 Divider (two furnished) for extending voltmeter range. Voltage error introduced is less than $\pm 6\%$ 1 MHz to 700 MHz, less than $\pm 12\%$ to 1 GHz; if used on one channel only, phase error introduced is less than $\pm (1 + 0.015f/\text{MHz})$ °.

10216A Isolator (two furnished) for eliminating effect of test-point impedance on sam-

pler*. Voltage error introduced is less than $\pm 6\%$ 1 to 200 MHz, response is 3 dB down at 500 MHz; if used on one channel only, phase error introduced is less than $\pm (3 + 0.185f/\text{MHz})$ °.

10213-62102 Ground Clips (six furnished) for 10214A and 10216A.

5020-0457 Probe Tips (six furnished).

Accessories Available:

10218A BNC Adapter, converts probe tip to male BNC connector, \$6.00.

10220A Adapter, for connection of Microdot screw-on coaxial connectors to the probe, \$3.50.

10221A 50-ohm Tee, with GR874 RF fittings, for monitoring signals in 50-ohm transmission line without terminating the line, \$40.00.

11529A Accessory Case, for convenient storage of accessories, includes two compartmented shelves and snap-shut lid, \$8.50.

1250-0778 Adapter, both connectors type N male (UG-57B/U).

1250-0780 Adapter, type N male and BNC female (UG-201A/U).

1250-0846 Adapter, Tee, all connectors type N female (UG-28A/U).

General Radio type 874-W50 50-ohm Load (also available from -hp- under part no. 0950-0090).

General Radio type 874-QNP Adapter, GR 874 and type N male (also available from -hp- under part no. 1250-0847).

General Radio type 874-QNJA Adapter, GR 874 and type N female (also available from -hp- under part no. 1250-0240).

General Radio type 874-QBPA Adapter, GR 874 and BNC male (also available from -hp- under part no. 1250-0849).

General Radio type 874-QBJA Adapter, GR 874 and BNC female (also available from -hp- under part no. 1250-0850).

Complementary Equipment:

774D Dual Directional Coupler, 215 to 450 MHz, \$200.00.

775D Dual Directional Coupler, 450 to 950 MHz, \$200.00.

8491A (Option 10) 10-dB Coaxial Attenuator, \$50.00.

8491A (Option 20) 20-dB Coaxial Attenuator, \$50.00.

Price: Model 8405A, \$2500.00.

Prices f.o.b. factory.

Data subject to change without notice.

* Variations in the high-frequency impedance of test points as the probe is shifted from point to point influence the samplers and can cause the indicated amplitude and phase errors. These errors are different from the effects of any test-point loading due to the input impedance of the probes.